

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination DEBOER ET AL.	
		10/763,597	Examiner	Art Unit David C. Thomas 1637

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Richter et al. Nanoscale palladium metallization of DNA. Advanced Materials (2000) 121:507-510.
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	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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